

# SK100MLI07F3TD1p



**SEMITOP® 4 Press-Fit**

## 3-Level NPC Inverter

### SK100MLI07F3TD1p

#### Features

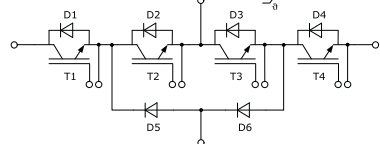
- One screw mounting module
- Solder free mounting with Press-Fit terminals
- Fully compatible with other SEMITOP® Press-Fit types
- Improved thermal performances by aluminum oxide substrate
- 650V Trench IGBT technology
- CAL4F technology FWD
- Rapid switching clamping diode technology
- Integrated NTC temperature sensor
- UL recognized, file no. E 63 532

#### Remarks\*

- Recommended  $T_{jop} = -40 \dots +150^\circ\text{C}$
- IGBT1: outer IGBTs T1 & T4
- IGBT2: inner IGBTs T2 & T3
- Diode1: outer Diodes D1 & D4
- Diode2: inner Diodes D2 & D3
- Diode5: clamping diodes D5 & D6

#### Footnotes

<sup>1)</sup> Please find further technical information on the SEMIKRON website.



**MLI-T**

| Absolute Maximum Ratings |  |                          |                  |
|--------------------------|--|--------------------------|------------------|
| Symbol                   | Conditions   | Values                   | Unit             |
| <b>IGBT1</b>             |  |                          |                  |
| $V_{CES}$                | $T_j = 25^\circ\text{C}$   | 650                      | V                |
| $I_C$                    | $T_j = 175^\circ\text{C}$  | $T_s = 25^\circ\text{C}$ | 109              |
|                          |  | $T_s = 70^\circ\text{C}$ | 87               |
| $I_{Cnom}$               |  | 100                      | A                |
| $I_{CRM}$                | $I_{CRM} = 3 \times I_{Cnom}$  | 300                      | A                |
| $V_{GES}$                |  | -20 ... 20               | V                |
| $t_{psc}$                | $V_{CC} = 400\text{ V}, V_{GE} \leq 15\text{ V}, T_j = 150^\circ\text{C}, V_{CES} \leq 650\text{ V}$ | 5                        | $\mu\text{s}$    |
| $T_j$                    |  | -40 ... 175              | $^\circ\text{C}$ |
| <b>IGBT2</b>             |  |                          |                  |
| $V_{CES}$                | $T_j = 25^\circ\text{C}$   | 650                      | V                |
| $I_C$                    | $T_j = 175^\circ\text{C}$  | $T_s = 25^\circ\text{C}$ | 178              |
|                          |  | $T_s = 70^\circ\text{C}$ | 143              |
| $I_{Cnom}$               |  | 150                      | A                |
| $I_{CRM}$                | $I_{CRM} = 3 \times I_{Cnom}$  | 450                      | A                |
| $V_{GES}$                |  | -20 ... 20               | V                |
| $t_{psc}$                | $V_{CC} = 360\text{ V}, V_{GE} \leq 15\text{ V}, T_j = 150^\circ\text{C}, V_{CES} \leq 650\text{ V}$ | 6                        | $\mu\text{s}$    |
| $T_j$                    |  | -40 ... 175              | $^\circ\text{C}$ |
| <b>Diode1</b>            |  |                          |                  |
| $V_{RRM}$                | $T_j = 25^\circ\text{C}$   | 650                      | V                |
| $I_F$                    | $T_j = 175^\circ\text{C}$  | $T_s = 25^\circ\text{C}$ | 137              |
|                          |  | $T_s = 70^\circ\text{C}$ | 107              |
| $I_{Fnom}$               |  | 100                      | A                |
| $I_{FRM}$                | $I_{FRM} = 2 \times I_{Fnom}$  | 200                      | A                |
| $I_{FSM}$                | 10 ms, sin 180°, $T_j = 25^\circ\text{C}$  | 990                      | A                |
| $T_j$                    |  | -40 ... 175              | $^\circ\text{C}$ |
| <b>Diode2</b>            |  |                          |                  |
| $V_{RRM}$                | $T_j = 25^\circ\text{C}$   | 650                      | V                |
| $I_F$                    | $T_j = 175^\circ\text{C}$  | $T_s = 25^\circ\text{C}$ | 137              |
|                          |  | $T_s = 70^\circ\text{C}$ | 107              |
| $I_{Fnom}$               |  | 100                      | A                |
| $I_{FRM}$                | $I_{FRM} = 2 \times I_{Fnom}$  | 200                      | A                |
| $I_{FSM}$                | 10 ms, sin 180°, $T_j = 25^\circ\text{C}$  | 990                      | A                |
| $T_j$                    |  | -40 ... 175              | $^\circ\text{C}$ |
| <b>Diode5</b>            |  |                          |                  |
| $V_{RRM}$                | $T_j = 25^\circ\text{C}$   | 650                      | V                |
| $I_F$                    | $T_j = 175^\circ\text{C}$  | $T_s = 25^\circ\text{C}$ | 138              |
|                          |  | $T_s = 70^\circ\text{C}$ | 108              |
| $I_{Fnom}$               |  | 120                      | A                |
| $I_{FRM}$                | $I_{FRM} = 2 \times I_{Fnom}$  | 240                      | A                |
| $I_{FSM}$                | 10 ms, sin 180°, $T_j = 25^\circ\text{C}$  | 684                      | A                |
| $T_j$                    |  | -40 ... 175              | $^\circ\text{C}$ |
| <b>Module</b>            |  |                          |                  |
| $I_t(\text{RMS})$        | $T_{\text{terminal}} = 100^\circ\text{C}, T_s = 60^\circ\text{C}, \text{ per pin}$                   | 40                       | A                |
| $T_{\text{stg}}$         |  | -40 ... 125              | $^\circ\text{C}$ |
| $V_{\text{isol}}$        | AC, sinusoidal, t = 1 min  | 2500                     | V                |

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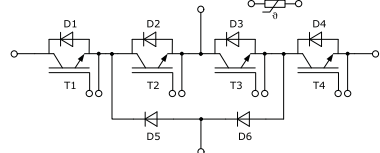
#### Remarks\*

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- Diode1: outer Diodes D1 & D4
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#### Footnotes

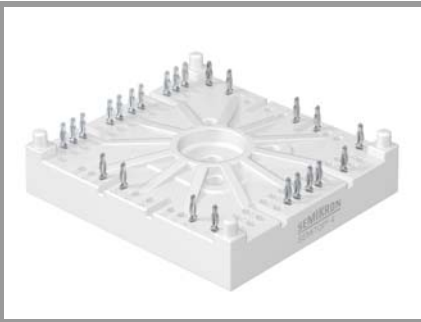
1) Please find further technical information on the SEMIKRON website.

| Characteristics |   |                           |      |       |      |            |
|-----------------|---|---------------------------|------|-------|------|------------|
| Symbol          | Conditions  |                           | min. | typ.  | max. | Unit       |
| <b>IGBT1</b>    |   |                           |      |       |      |            |
| $V_{CE(sat)}$   | $I_C = 100\text{ A}$<br>$V_{GE} = 15\text{ V}$<br>chipelevel                          | $T_j = 25^\circ\text{C}$  |      | 1.85  | 2.22 | V          |
|                 |   | $T_j = 150^\circ\text{C}$ |      | 2.18  | 2.55 | V          |
| $V_{CE0}$       | chipelevel  | $T_j = 25^\circ\text{C}$  |      | 1.10  | 1.20 | V          |
|                 |   | $T_j = 150^\circ\text{C}$ |      | 1.00  | 1.10 | V          |
| $r_{CE}$        | $V_{GE} = 15\text{ V}$<br>chipelevel  | $T_j = 25^\circ\text{C}$  |      | 7.5   | 10   | m $\Omega$ |
|                 |   | $T_j = 150^\circ\text{C}$ |      | 12    | 15   | m $\Omega$ |
| $V_{GE(th)}$    | $V_{GE} = V_{CE}, I_C = 1.6\text{ mA}$  |                           | 4.2  | 5.1   | 5.6  | V          |
| $I_{CES}$       | $V_{GE} = 0\text{ V}, V_{CE} = 650\text{ V}, T_j = 25^\circ\text{C}$                  |                           |      |       | 0.2  | mA         |
| $C_{ies}$       | $V_{CE} = 25\text{ V}$<br>$V_{GE} = 0\text{ V}$                                       | $f = 1\text{ MHz}$        |      | 6.2   |      | nF         |
| $C_{oes}$       |   | $f = 1\text{ MHz}$        |      | 0.232 |      | nF         |
| $C_{res}$       |   | $f = 1\text{ MHz}$        |      | 0.18  |      | nF         |
| $Q_G$           | $V_{GE} = -15\text{ V} \dots +15\text{ V}$  |                           |      | 1180  |      | nC         |
| $R_{Gint}$      | $T_j = 25^\circ\text{C}$  |                           |      | 2.4   |      | $\Omega$   |
| $t_{d(on)}$     | $V_{CE} = 300\text{ V}$   | $T_j = 150^\circ\text{C}$ |      | 155   |      | ns         |
| $t_r$           | $I_C = 100\text{ A}$  | $T_j = 150^\circ\text{C}$ |      | 51    |      | ns         |
| $E_{on}$        | $V_{GE} = +15/-15\text{ V}$   | $T_j = 150^\circ\text{C}$ |      | 4.6   |      | mJ         |
| $t_{d(off)}$    | $R_{G on} = 1.8\ \Omega$  | $T_j = 150^\circ\text{C}$ |      | 260   |      | ns         |
| $t_f$           | $R_{G off} = 1.8\ \Omega$   | $T_j = 150^\circ\text{C}$ |      | 19    |      | ns         |
| $E_{off}$       | $di/dt_{on} = 1980\text{ A}/\mu\text{s}$<br>$di/dt_{off} = 4540\text{ A}/\mu\text{s}$ | $T_j = 150^\circ\text{C}$ |      | 1     |      | mJ         |
|                 |   |                           |      |       |      |            |
| $R_{th(j-s)}$   | per IGBT, $\lambda_{paste} = 0.8\text{ W}/(\text{mK})$                                |                           |      | 0.5   |      | K/W        |
| <b>IGBT2</b>    |   |                           |      |       |      |            |
| $V_{CE(sat)}$   | $I_C = 150\text{ A}$<br>$V_{GE} = 15\text{ V}$<br>chipelevel                          | $T_j = 25^\circ\text{C}$  |      | 1.45  | 1.77 | V          |
|                 |   | $T_j = 150^\circ\text{C}$ |      | 1.70  | 2.10 | V          |
| $V_{CE0}$       | chipelevel  | $T_j = 25^\circ\text{C}$  |      | 0.90  | 1.00 | V          |
|                 |   | $T_j = 150^\circ\text{C}$ |      | 0.82  | 0.90 | V          |
| $r_{CE}$        | $V_{GE} = 15\text{ V}$<br>chipelevel  | $T_j = 25^\circ\text{C}$  |      | 3.7   | 5.1  | m $\Omega$ |
|                 |   | $T_j = 150^\circ\text{C}$ |      | 5.9   | 8.0  | m $\Omega$ |
| $V_{GE(th)}$    | $V_{GE} = V_{CE}, I_C = 2.4\text{ mA}$  |                           | 5.1  | 5.8   | 6.4  | V          |
| $I_{CES}$       | $V_{GE} = 0\text{ V}, V_{CE} = 650\text{ V}, T_j = 25^\circ\text{C}$                  |                           |      |       | 0.2  | mA         |
| $C_{ies}$       | $V_{CE} = 25\text{ V}$<br>$V_{GE} = 0\text{ V}$                                       | $f = 1\text{ MHz}$        |      | 9.24  |      | nF         |
| $C_{oes}$       |   | $f = 1\text{ MHz}$        |      | 0.6   |      | nF         |
| $C_{res}$       |   | $f = 1\text{ MHz}$        |      | 0.274 |      | nF         |
| $Q_G$           | $V_{GE} = -15\text{ V} \dots +15\text{ V}$  |                           |      | 1360  |      | nC         |
| $R_{Gint}$      | $T_j = 25^\circ\text{C}$  |                           |      | 2.0   |      | $\Omega$   |
| $t_{d(on)}$     | $V_{CE} = 300\text{ V}$   | $T_j = 150^\circ\text{C}$ |      | 69    |      | ns         |
| $t_r$           | $I_C = 150\text{ A}$  | $T_j = 150^\circ\text{C}$ |      | 47    |      | ns         |
| $E_{on}$        | $V_{GE} = +15/-15\text{ V}$   | $T_j = 150^\circ\text{C}$ |      | 3.5   |      | mJ         |
| $t_{d(off)}$    | $R_{G on} = 3\ \Omega$  | $T_j = 150^\circ\text{C}$ |      | 288   |      | ns         |
| $t_f$           | $R_{G off} = 3\ \Omega$   | $T_j = 150^\circ\text{C}$ |      | 43    |      | ns         |
| $E_{off}$       | $di/dt_{on} = 3460\text{ A}/\mu\text{s}$<br>$di/dt_{off} = 2010\text{ A}/\mu\text{s}$ | $T_j = 150^\circ\text{C}$ |      | 4     |      | mJ         |
|                 |   |                           |      |       |      |            |
| $R_{th(j-s)}$   | per IGBT, $\lambda_{paste} = 0.8\text{ W}/(\text{mK})$                                |                           |      | 0.35  |      | K/W        |



MLI-T

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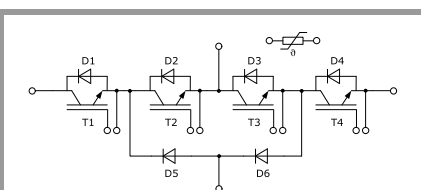
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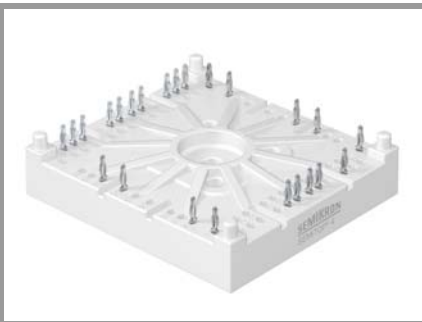
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| Characteristics       |   |                           |                           |      |      |      |
|-----------------------|---|---------------------------|---------------------------|------|------|------|
| Symbol                | Conditions  |                           | min.                      | typ. | max. | Unit |
| <b>Diode1</b>         |   |                           |                           |      |      |      |
| $V_F = V_{EC}$        | $I_F = 100 \text{ A}$   | $T_j = 25^\circ\text{C}$  |                           | 1.37 | 1.73 | V    |
|                       |   | chiplevel                 | $T_j = 150^\circ\text{C}$ | 1.35 | 1.72 | V    |
| $V_{F0}$              | chiplevel   | $T_j = 25^\circ\text{C}$  |                           | 1.04 | 1.24 | V    |
|                       |   | $T_j = 150^\circ\text{C}$ |                           | 0.85 | 0.99 | V    |
| $r_F$                 | chiplevel   | $T_j = 25^\circ\text{C}$  |                           | 3.3  | 4.9  | mΩ   |
|                       |   | $T_j = 150^\circ\text{C}$ |                           | 5.0  | 7.3  | mΩ   |
| $I_{RRM}$             | $I_F = 150 \text{ A}$   | $T_j = 150^\circ\text{C}$ |                           | 135  |      | A    |
| $Q_{rr}$              | $di/dt_{off} = 3460 \text{ A}/\mu\text{s}$<br>$V_R = 300 \text{ V}$ | $T_j = 150^\circ\text{C}$ |                           | 13.8 |      | μC   |
| $E_{rr}$              | $V_{GE} = +15/-15 \text{ V}$  | $T_j = 150^\circ\text{C}$ |                           | 1.76 |      | mJ   |
| $R_{th(j-s)}$         | per Diode, $\lambda_{paste}=0.8 \text{ W}/(\text{mK})$              |                           |                           | 0.58 |      | K/W  |
| <b>Diode2</b>         |   |                           |                           |      |      |      |
| $V_F = V_{EC}$        | $I_F = 100 \text{ A}$   | $T_j = 25^\circ\text{C}$  |                           | 1.37 | 1.73 | V    |
|                       |   | chiplevel                 | $T_j = 150^\circ\text{C}$ | 1.35 | 1.72 | V    |
| $V_{F0}$              | chiplevel   | $T_j = 25^\circ\text{C}$  |                           | 1.04 | 1.24 | V    |
|                       |   | $T_j = 150^\circ\text{C}$ |                           | 0.85 | 0.99 | V    |
| $r_F$                 | chiplevel   | $T_j = 25^\circ\text{C}$  |                           | 3.3  | 4.9  | mΩ   |
|                       |   | $T_j = 150^\circ\text{C}$ |                           | 5.0  | 7.3  | mΩ   |
| $I_{RRM}$             | $I_F = 100 \text{ A}$   | $T_j = 150^\circ\text{C}$ |                           | -    |      | A    |
| $Q_{rr}$              | $V_R = 300 \text{ V}$   | $T_j = 150^\circ\text{C}$ |                           | -    |      | μC   |
| $E_{rr} \text{ } ^1)$ | $V_{GE} = +15/-15 \text{ V}$  | $T_j = 150^\circ\text{C}$ |                           | -    |      | mJ   |
| $R_{th(j-s)}$         | per Diode, $\lambda_{paste}=0.8 \text{ W}/(\text{mK})$              |                           |                           | 0.58 |      | K/W  |
| <b>Diode5</b>         |   |                           |                           |      |      |      |
| $V_F = V_{EC}$        | $I_F = 120 \text{ A}$   | $T_j = 25^\circ\text{C}$  |                           | 1.35 | 1.77 | V    |
|                       |   | chiplevel                 | $T_j = 150^\circ\text{C}$ | 1.30 | 1.72 | V    |
| $V_{F0}$              | chiplevel   | $T_j = 25^\circ\text{C}$  |                           | 0.95 | 1.15 | V    |
|                       |   | $T_j = 150^\circ\text{C}$ |                           | 0.75 | 0.95 | V    |
| $r_F$                 | chiplevel   | $T_j = 25^\circ\text{C}$  |                           | 3.3  | 5.2  | mΩ   |
|                       |   | $T_j = 150^\circ\text{C}$ |                           | 4.6  | 6.4  | mΩ   |
| $I_{RRM}$             | $I_F = 120 \text{ A}$   | $T_j = 150^\circ\text{C}$ |                           | 73   |      | A    |
| $Q_{rr}$              | $di/dt_{off} = 2100 \text{ A}/\mu\text{s}$<br>$V_R = 300 \text{ V}$ | $T_j = 150^\circ\text{C}$ |                           | 6.9  |      | μC   |
| $E_{rr}$              | $V_{GE} = +15/-15 \text{ V}$  | $T_j = 150^\circ\text{C}$ |                           | 0.9  |      | mJ   |
| $R_{th(j-s)}$         | per Diode, $\lambda_{paste}=0.8 \text{ W}/(\text{mK})$              |                           |                           | 0.6  |      | K/W  |



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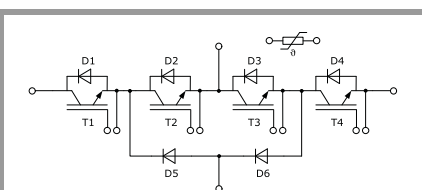
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| Characteristics           |   |      |                           |      |      |
|---------------------------|---|------|---------------------------|------|------|
| Symbol                    | Conditions  | min. | typ.                      | max. | Unit |
| <b>Module</b>             |   |      |                           |      |      |
| $L_{sCE1}$                |   |      | -                         |      | nH   |
| $L_{sCE2}$                |   |      | -                         |      | nH   |
| $R_{CC'+EE'}$             |   |      | $T_s = 25^\circ\text{C}$  | -    | mΩ   |
|                           |   |      | $T_s = 125^\circ\text{C}$ | -    | mΩ   |
| $M_s$                     | to heatsink   | 2.5  |                           | 2.75 | Nm   |
| $M_t$                     |   |      |                           | -    | Nm   |
|                           |   |      |                           | -    | Nm   |
| $w$                       |   |      | 60                        |      | g    |
| <b>Temperature Sensor</b> |   |      |                           |      |      |
| $R_{100}$                 | $T_c = 100^\circ\text{C}$ ( $R_{25} = 5 \text{ k}\Omega$ )  |      | $493 \pm 5\%$             |      | Ω    |
| $B_{100/125}$             | $R(T) = R_{100} \exp[B_{100/125}(1/T - 1/T_{100})]$ ; T[K]; |      | $3550 \pm 2\%$            |      | K    |



**MLI-T**

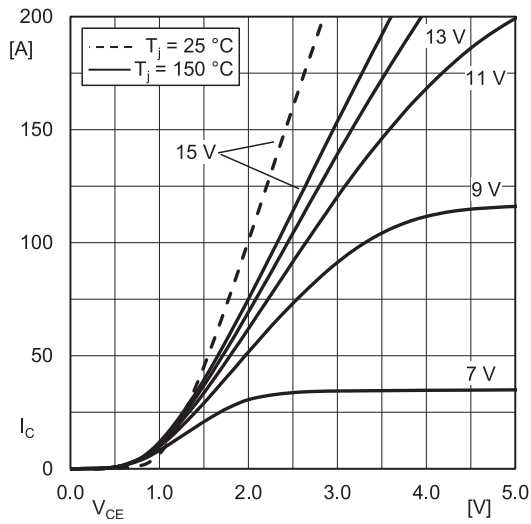


Fig. 1: Typ. IGBT1 output characteristic, incl.  $R_{CC'+EE'}$

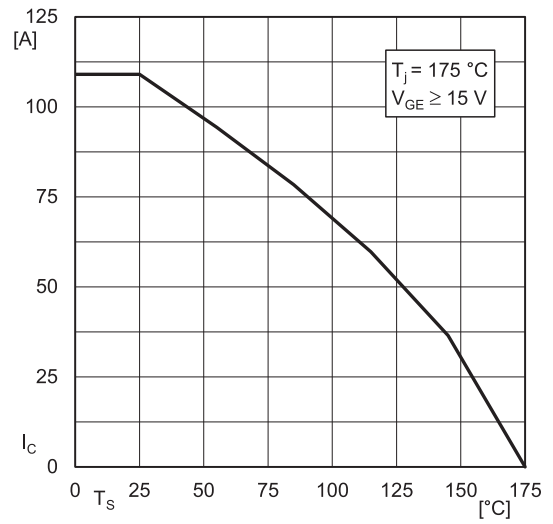


Fig. 2: IGBT1 rated current vs. Temperature  $I_C=f(T_s)$

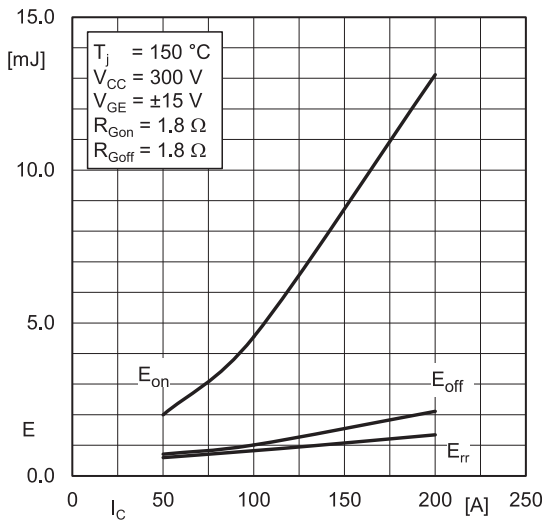


Fig. 3: Typ. IGBT1 & Diode5 turn-on /-off energy =  $f(I_C)$

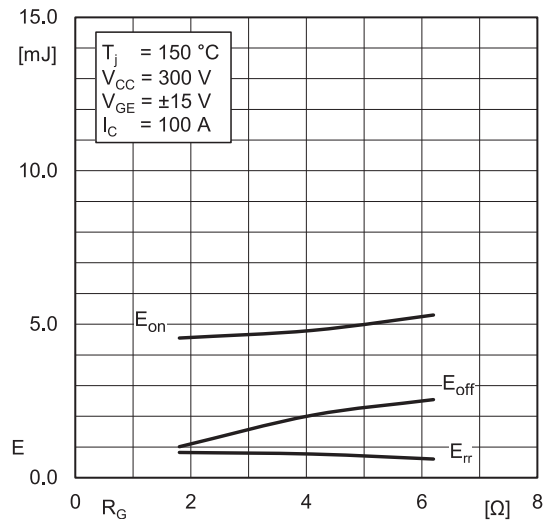


Fig. 4: Typ. IGBT1 & Diode5 turn-on /-off energy =  $f(R_G)$

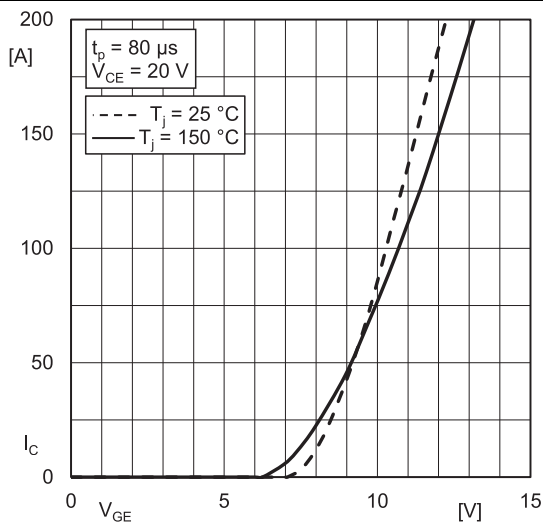


Fig. 5: Typ. IGBT1 transfer characteristic

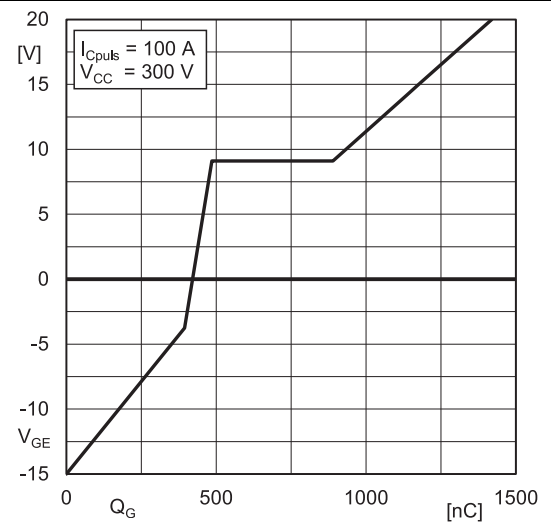


Fig. 6: Typ. IGBT1 gate charge characteristic

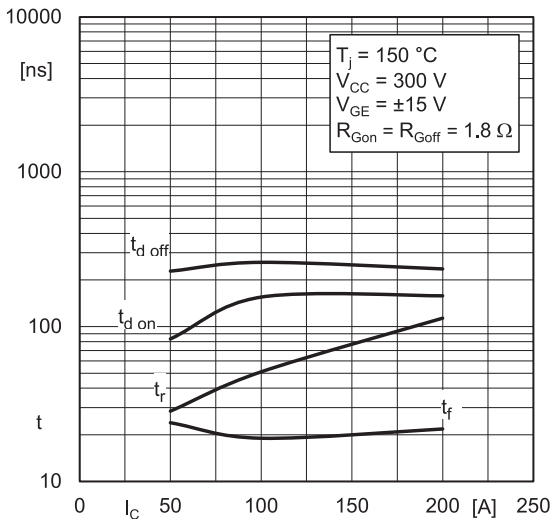


Fig. 7: Typ. IGBT1 switching times vs.  $I_c$

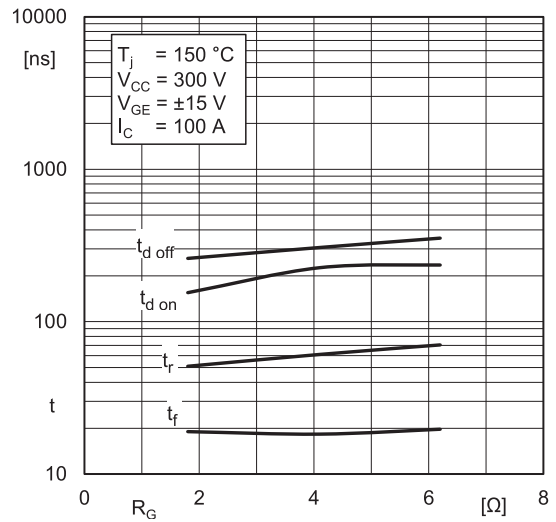


Fig. 8: Typ. IGBT1 switching times vs. gate resistor  $R_G$

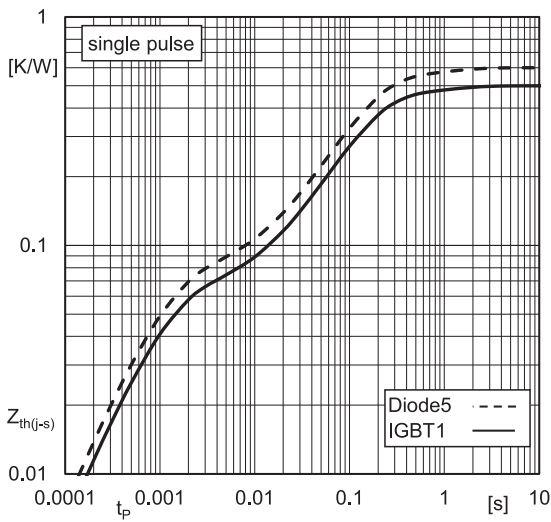


Fig. 9: Transient thermal impedance of IGBT1 & Diode5

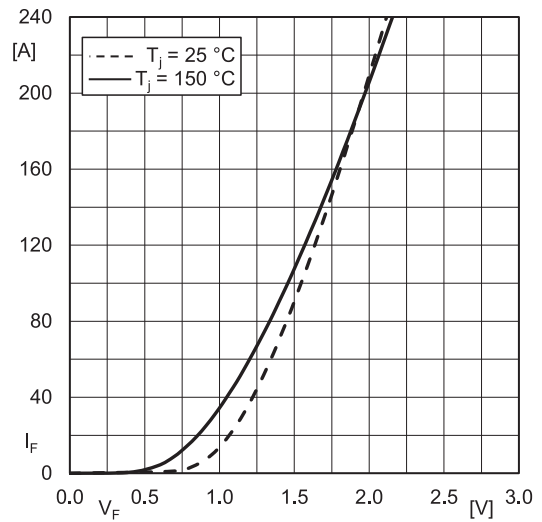


Fig. 10: Typ. Diode5 forward characteristic, incl.  $R_{CC+EE'}$

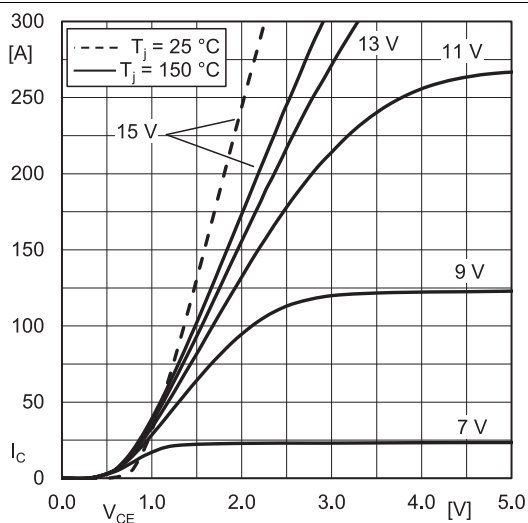


Fig. 13: Typ. IGBT2 output characteristic, incl.  $R_{CC+EE'}$

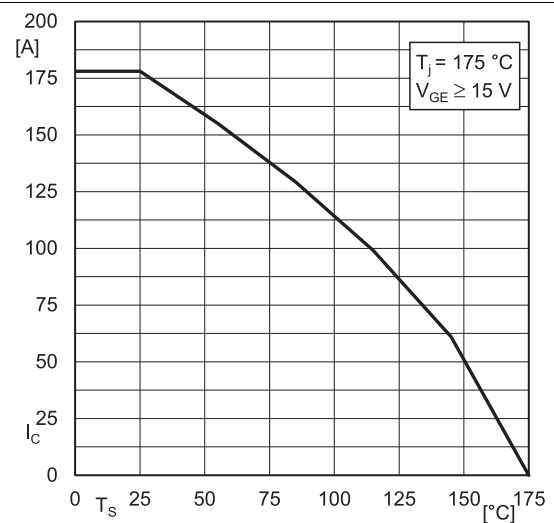


Fig. 14: IGBT2 Rated current vs. Temperature  $I_c = f(T_s)$

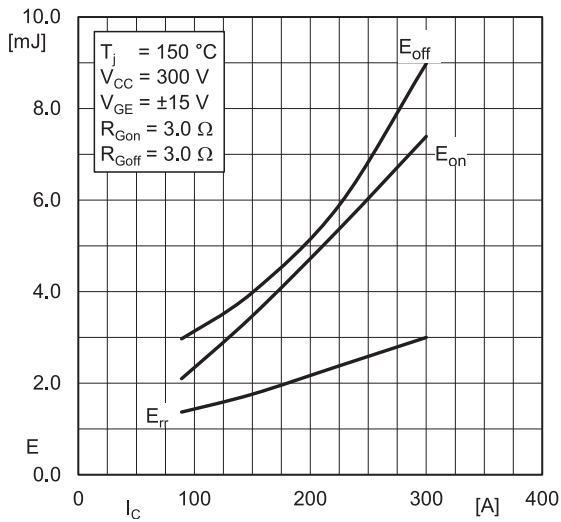


Fig. 15: Typ. IGBT2 & Diode1 turn-on /-off energy =  $f(I_C)$

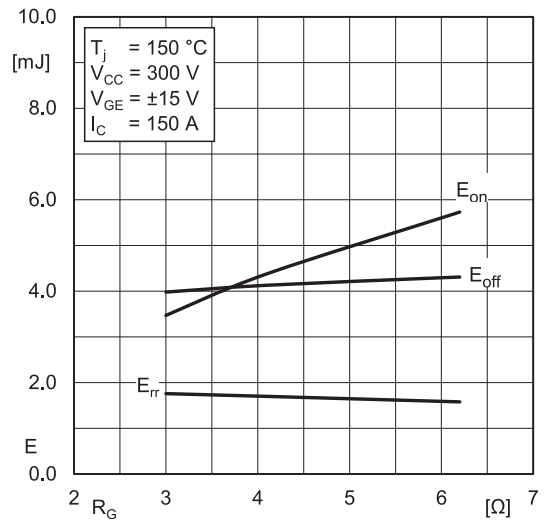


Fig. 16: Typ. IGBT2 & Diode1 turn-on / -off energy =  $f(R_G)$

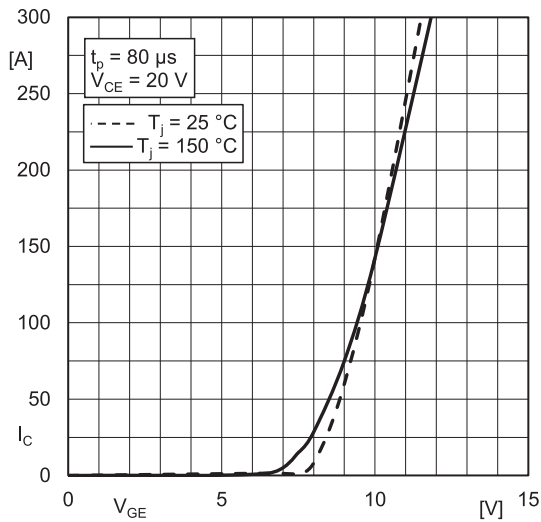


Fig. 17: Typ. IGBT2 transfer characteristic

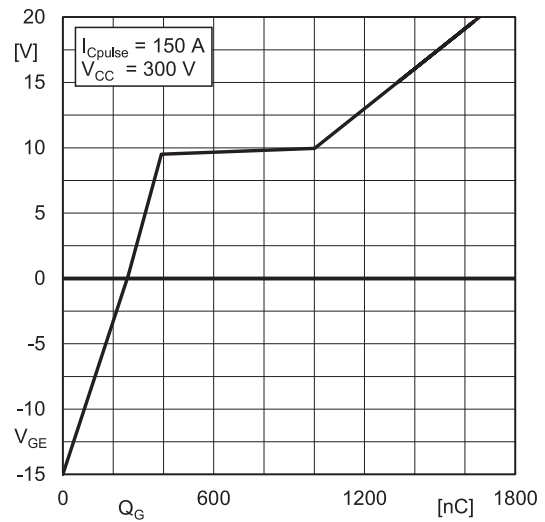


Fig. 18: Typ. IGBT2 gate charge characteristic

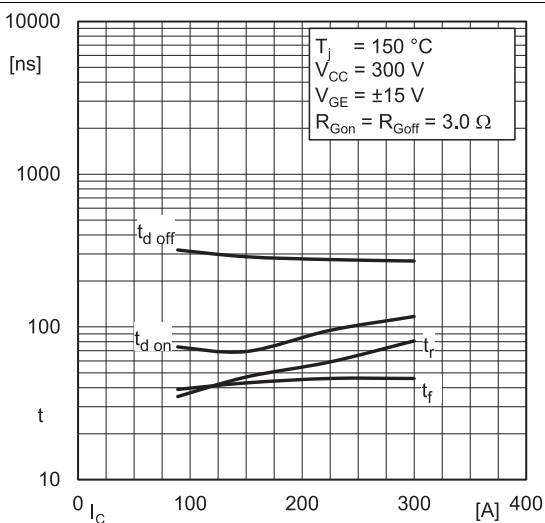


Fig. 19: Typ. IGBT2 switching times vs.  $I_C$

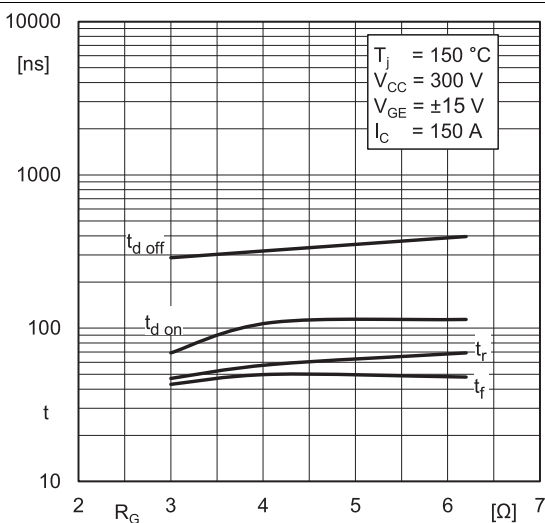


Fig. 20: Typ. IGBT2 switching times vs. gate resistor  $R_G$

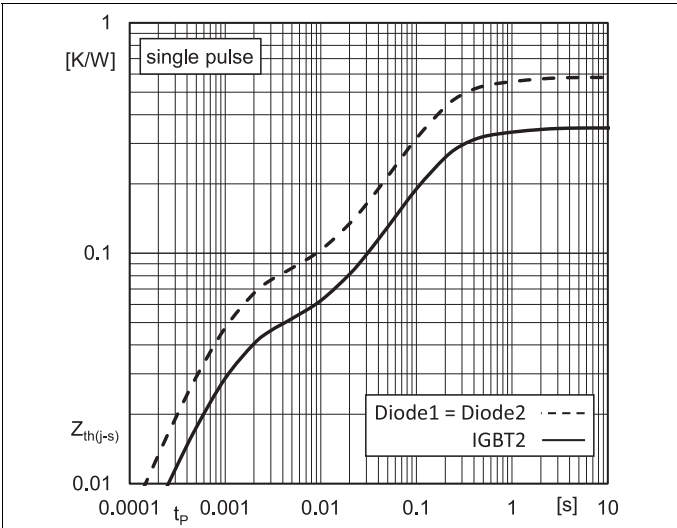


Fig. 21: Transient thermal impedance of IGBT2, Diode1 & Diode2

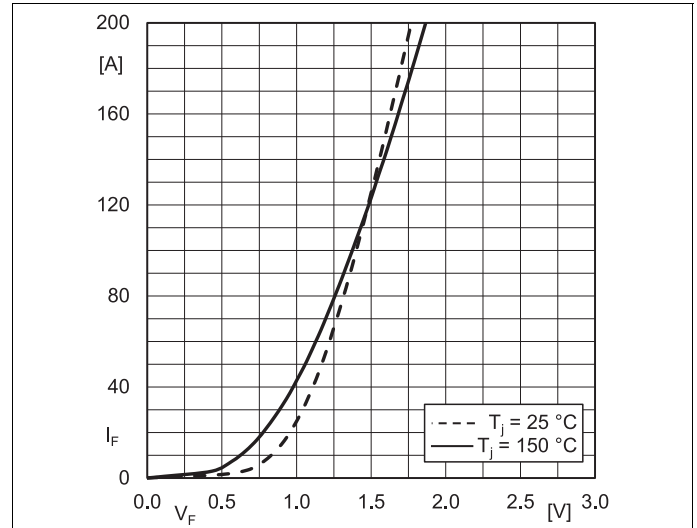


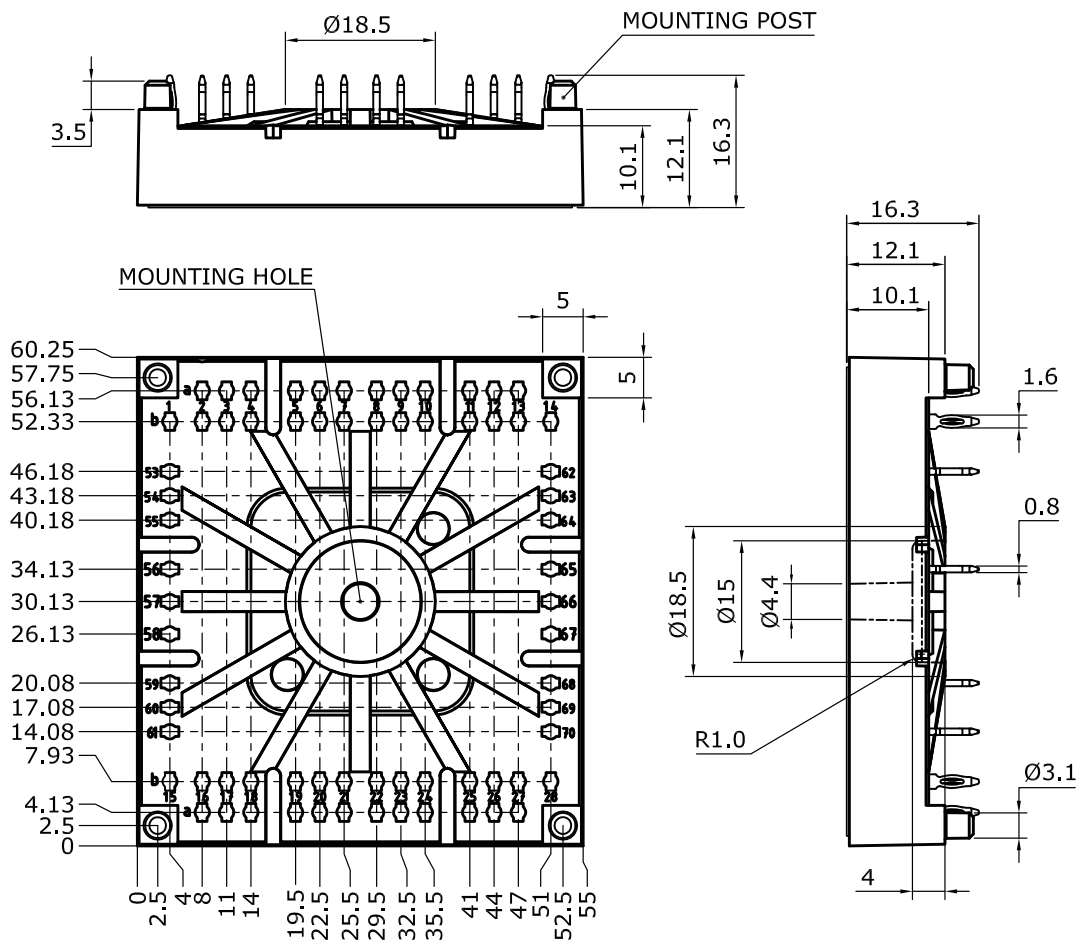
Fig. 22: Typ. Diode1 & Diode2 forward characteristic, incl.  $R_{CC+EE'}$



# SK100MLI07F3TD1p

Dimensions: mm

Tolerance system: ISO 2768-m



Suggested drilled hole diameter for terminal pins in the circuit board:

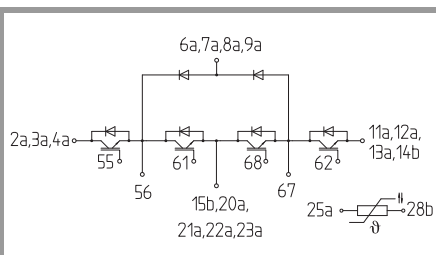
- minimum: 1.575 mm
- typical: 1.6 mm
- maximum: 1.625 mm

Suggested hole diameter for the mounting post in the circuit board:

- 3.6 mm

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SEMIPOT 4 Press-Fit



MLI-T

This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, chapter IX.

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